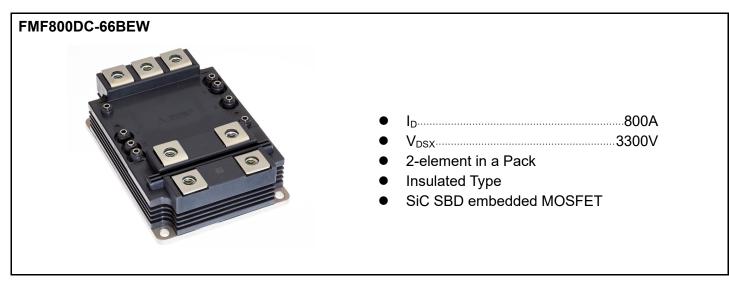


## **Preliminary**

## FMF800DC-66BEW

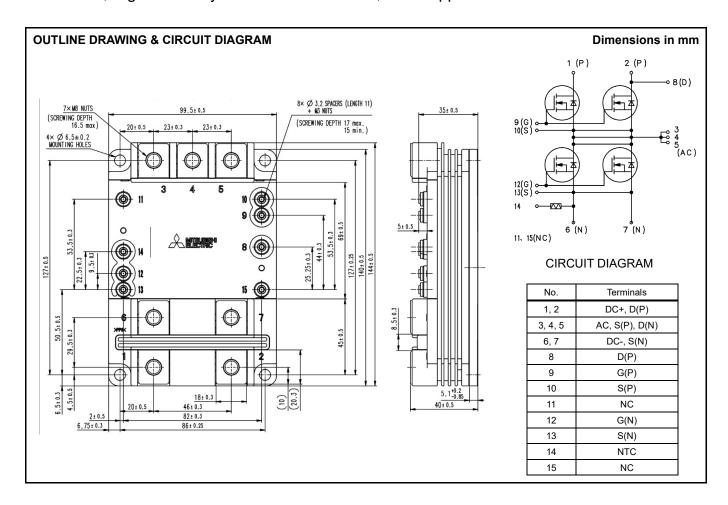
HIGH POWER SWITCHING USE

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules



#### **APPLICATION**

Traction drives, High Reliability Converters / Inverters, DC choppers



## FMF800DC-66BEW

HIGH POWER SWITCHING USE

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **MAXIMUM RATINGS**

Item	Symbol	Condiitons			Unit
Drain-Source voltage, specified gate-source voltage	$V_{DSX}$	V <sub>GS</sub> = -7 V	T <sub>j</sub> = -40~175 °C		V
Gate-Source voltage	$V_{GSS}$	V <sub>DS</sub> = 0 V	T <sub>j</sub> = -40~175 °C	±20	V
Drain current	I <sub>D</sub>	$V_{GS}$ = 17 V , $T_c$ = 87 °C , AC terminal output current(No	ote 1)	800	Α
Drain current	I <sub>DP</sub>	Non repetitive pulse	$T_j = T_{op}$	1600	Α
Reverse drain current (FWD forward current)	Is	$V_{GS}$ = -7 V , $T_c$ = 85 °C , AC terminal output current(No	te 1)	800	Α
Reverse drain current (FWD forward current)	I <sub>SP</sub>	Non repetitive pulse	$T_j = T_{op}$	1600	Α
Total power dissipation	P <sub>tot</sub>	T <sub>c</sub> = 25 °C , MOSFET part(Note 2)			W
Isolation voltage	$V_{isol}$	Charged part to the baseplate RMS sinusoidal, 60 Hz 1 min			Vrms
Partial discharge charge	$Q_{pd}$	Charged part to the baseplate RMS sinusoidal, 60 Hz 1 min V1 = 3500 V, V2 = 2600 V (acc. to IEC 61287-1)			рC
Junction temperature	Tj	Maximum temperature range in off-state or on-state (non-switching)			°C
Case temperature	T <sub>c</sub>	Maximum case temperature range in on-state			°C
Storage temperature	$T_{stg}$	Maximum case temperature range in off-state			°C
Operating junction temperature	$T_jop$	Maximum junction temperature range for switching operation			°C
Short-circuit withstand pulse duration	t <sub>pSC</sub>	$V_{DD}$ = 2500 V , $V_{GS}$ = +17 / -7 V , $L_s$ = 40 nH , VGS50%-VGS50%	$T_j = T_{op}$	1.7	μs
Non-repetitive surge forward current	I <sub>FSM</sub>	t <sub>p</sub> = 10ms, Half sinewave	T <sub>j</sub> = 175 °C	5.9	kA
I2t value	l <sup>2</sup> t	$t_p$ = 10ms, Half sinewave	T <sub>j</sub> = 175 °C	180	kA2s

#### **ELECTRICAL CHARACTERISTICS**

Item	Symbol	Conditions			Limits		Unit
item	Symbol			Min.	Тур.	Max.	Offic
Gate-source leakage current	$I_{GSS}$	$V_{DS} = 0 \text{ V}$ , $V_{GS} = V_{GSS}$	T <sub>j</sub> = 25 °C	-2.0	-	2.0	μΑ
			T <sub>j</sub> = 25 °C	-	0.003	-	mA
Drain-source cut-off current	I <sub>DSX</sub>	$V_{DS} = V_{DSX}$ , $V_{GS} = -7 V$	T <sub>j</sub> = 150 °C	-	0.050	-	mA
			T <sub>j</sub> = 175 °C	-	0.080	3.0	mA
		V <sub>DS</sub> = 10 V , I <sub>D</sub> = 80mA	T <sub>j</sub> = 25 °C	1.60	2.10	2.60	V
Gate-source threshold voltage	$V_{GS(th)}$		T <sub>j</sub> = 150 °C	-	1.50	-	V
			T <sub>j</sub> = 175 °C	0.90	1.45	1.90	٧
		V <sub>DS</sub> = VDS(on) , V <sub>GS</sub> = 17 V , (Note 3)	T <sub>j</sub> = 25 °C	-	2.00	-	mΩ
Drain-source on resistance	r <sub>DS(on)</sub>		T <sub>j</sub> = 150 °C	-	4.31	-	mΩ
			T <sub>j</sub> = 175 °C	-	5.00	6.06	mΩ
		I <sub>D</sub> = 800 A , V <sub>GS</sub> = 17 V , (Note 3)	T <sub>j</sub> = 25 °C	-	1.60	-	V
Drain-source on-state voltage	$V_{DS(on)}$		T <sub>j</sub> = 150 °C	-	3.45	-	٧
			T <sub>j</sub> = 175 °C	-	4.00	4.85	V
			T <sub>j</sub> = 25 °C	-	1.45	-	V
Source-drain voltage	$V_{SD(on)}$	I <sub>S</sub> = 800 A , V <sub>GS</sub> = 17 V , (Note 3, 4)	T <sub>j</sub> = 150 °C	-	3.25	-	٧
			T <sub>j</sub> = 175 °C	-	3.80	4.40	٧
			T <sub>j</sub> = 25 °C	-	2.00	-	٧
Source-drain voltage	$V_{SD}$	$I_S = 800 \text{ A}$ , $V_{GS} = 0 \text{ V}$ , (Note 3, 4)	T <sub>j</sub> = 150 °C	-	3.85	-	٧
			T <sub>j</sub> = 175 °C	-	4.35	5.00	V
			T <sub>j</sub> = 25 °C	-	2.00	-	V
Source-drain voltage	$V_{SD(off)}$	$I_S = 800 \text{ A}$ , $V_{GS} = -7 \text{ V}$ , (Note 3, 4)	T <sub>j</sub> = 150 °C	-	3.85	-	٧
			T <sub>j</sub> = 175 °C	-	4.35	5.00	V

## FMF800DC-66BEW

HIGH POWER SWITCHING USE

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **ELECTRICAL CHARACTERISTICS (continuation)**

Item	Symbol	Conditions			Unit		
Hem	Cyrribor			Min.	Тур.	Max.	Offic
Input capacitance	C <sub>iss</sub>	$V_{DS} = 10 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , f = 100kHz , 1/2 module	T <sub>j</sub> = 25 °C	-	110	-	nF
Output capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , f = 100kHz , 1/2 module	T <sub>j</sub> = 25 °C	-	70	-	nF
Reverse transfer capacitance	C <sub>rss</sub>	$V_{DS} = 10 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 100 \text{kHz}$ , $1/2 \text{ module}$	T <sub>j</sub> = 25 °C	-	2.7	-	nF
Gate charge	$Q_G$	$V_{DD}$ = 1800 V , $I_{D}$ = 800 A , $V_{GS}$ = +17 / -7 V , 1/2 module	T <sub>j</sub> = 25 °C	-	3.3	-	μC
		$V_{DD}=1800~V~,~I_D=800~A~,~V_{GS}=+17~/~-7~V~,~L_s=40~nH~,$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=1.5~\Omega~,~Inductive~load$	T <sub>j</sub> = 25 °C	-	0.36	-	μs
Turn-on delay time	t <sub>d(on)</sub>		T <sub>j</sub> = 150 °C	-	0.32	-	μs
			T <sub>j</sub> = 175 °C	-	0.32	0.50	μs
Rise time	lt l	$V_{DD} = 1800 \text{ V}$ , $I_{D} = 800 \text{ A}$ , $V_{GS} = +17 / -7 \text{ V}$ , $L_{s} = 40 \text{ nH}$ , $R_{G(nn)} = 1.5 \Omega$ , $R_{G(nf)} = 1.5 \Omega$ , Inductive load	T <sub>j</sub> = 25 °C	-	0.18	-	μs
			T <sub>j</sub> = 150 °C	-	0.15	-	μs
			T <sub>j</sub> = 175 °C	-	0.15	0.30	μs
Turn-on (switching) energy per pulse 10% integral	E <sub>on(10%)</sub>	$V_{DD}=1800~V~,~I_D=800~A~,~V_{GS}=+17~/~7~V~,~L_s=40~nH~,$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=1.5~\Omega~,~Inductive~load$	T <sub>j</sub> = 25 °C	-	0.24	-	J/P
			T <sub>j</sub> = 150 °C	-	0.20	-	J/P
			T <sub>j</sub> = 175 °C	-	0.20	-	J/P
	t-/-m	$V_{DD}=1800~V~,~I_D=800~A~,~V_{GS}=+17~/~7~V~,~L_s=40~nH~,$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=1.5~\Omega~,~Inductive~load$	T <sub>j</sub> = 25 °C	-	0.50	-	μs
Turn-off delay time			T <sub>j</sub> = 150 °C	-	0.61	-	μs
			T <sub>j</sub> = 175 °C	-	0.64	-	μs
	t <sub>c</sub>	$V_{DD}=1800~V~,~I_D=800~A~,~V_{GS}=+17~/~7~V~,~L_s=40~nH~,$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=1.5~\Omega~,~Inductive~load$	T <sub>j</sub> = 25 °C	-	0.17	-	μs
Fall time			T <sub>j</sub> = 150 °C	-	0.19	-	μs
			T <sub>j</sub> = 175 °C	-	0.19	-	μs
Turn-off (switching) energy per pulse 10% integral	E <sub>off(10%)</sub>	$V_{DD} = 1800 \text{ V}$ , $I_{D} = 800 \text{ A}$ , $V_{GS} = +17 / -7 \text{ V}$ , $L_{s} = 40 \text{ nH}$ , $R_{G(m)} = 1.5 \Omega$ , $R_{G(m)} = 1.5 \Omega$ , Inductive load	T <sub>j</sub> = 25 °C	-	0.11	-	J/P
			T <sub>j</sub> = 150 °C	-	0.13	-	J/P
			T <sub>j</sub> = 175 °C	-	0.13	-	J/P

#### THERMAL CHARACTERISTICS

Item	Symbol	Conditions		Limits		
	Symbol			Тур.	Max.	Unit
Thermal resistance junction to case	R <sub>th(j-c)</sub>	Junction to Case, MOSFET + embeded SBD part,1/2 module	1	-	22.5	K/kW
Contact thermal resistance, case to heatsink	R	Case to heat sink $\lambda_{\text{grease}}$ = 1W/m·K, D(c-s) = 70 $\mu$ m, 1/2 module	-	22.5	-	K/kW

## FMF800DC-66BEW

**HIGH POWER SWITCHING USE** 

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **MECHANICAL CHARACTERISTICS**

Item	Symbol	Conditions		Unit		
item	Symbol	Conditions		Тур.	Max.	Offic
Mounting torque	M <sub>t</sub>	Main terminals screw M8 This is the case when installing the product on the bus bar	7.0	-	22.0	N∙m
Mounting torque	M <sub>t</sub>	Mounting screw M6	3.0	-	6.0	N⋅m
Mounting torque	M <sub>t</sub>	Auxiliary terminals screw M3	0.4	-	0.8	N⋅m
mass, Mass(IEC)	m	-	-	0.8	-	kg
Comparative tracking index	CTI	-	600	-	-	-
Clearance distance in air	d <sub>a</sub>	Between main terminal	8.0	-	-	mm
Creepage distance along surface	d <sub>s</sub>	-	32.0	-	-	mm
Internal inductance, D-S	L <sub>P DS</sub>	Between DC+ and DC- (terminal 1,2-6,7)	-	14	-	nΗ
	L <sub>P DS</sub>	Between DC+ and AC (terminal 1,2-3,4,5)	-	40	-	nΗ
	L <sub>P DS</sub>	Between AC and DC- (terminal 3,4,5-6,7)	-	40	-	nΗ
Internal lead resistance, DD'-SS'	R <sub>DD'+SS'</sub>	Tc=25°C, Between DC+ and DC- (terminal 1,2-6,7)	-	0.46	-	mΩ
	R <sub>DD'+SS'</sub>	Tc=25°C, Between DC+ and AC (terminal 1,2-3,4,5)	-	0.22	-	mΩ
	R <sub>DD'+SS'</sub>	Tc=25°C, Between AC and DC- (terminal 3,4,5-6,7)	-	0.33	-	mΩ
Zero-power resistance	R <sub>25</sub>	T <sub>C</sub> =25°C	4.65	5.00	5.35	kΩ
B-constant	B <sub>(25/50)</sub>	-	-	3375	-	K
Screw hole depth for auxiliary electrode	I	M3	15	-	17	mm

Note 1. Control Case Temperature (Tc) so that the junction temperature (T<sub>i</sub>) does not exceed the maximum rating.

Note 2. Junction temperature (Tj) should not exceed Tjmax rating.

Note 3. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note 4. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

Note 5.  $B_{(25/50)} = \ln{\left(\frac{R_{25}}{R_{50}}\right)} / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$ 

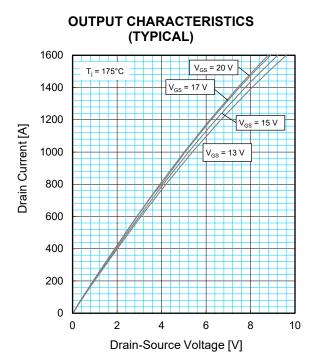
 $R_{25}$ : resistance at absolute temperature  $T_{25}[K]$ ;  $T_{25} = 25[^{\circ}C] + 273.15 = 298.15[K]$ 

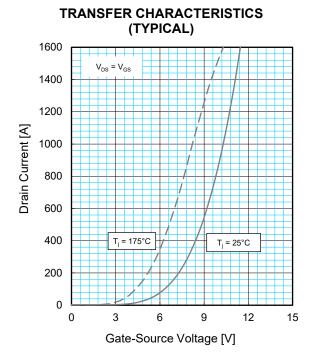
 $R_{50}$ : resistance at absolute temperature  $T_{50}\,[K];\,T_{50}$  =  $50[^{o}C]$  + 273.15 = 323.15[K]

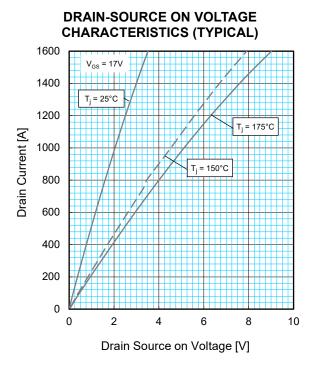
**HIGH POWER SWITCHING USE** 

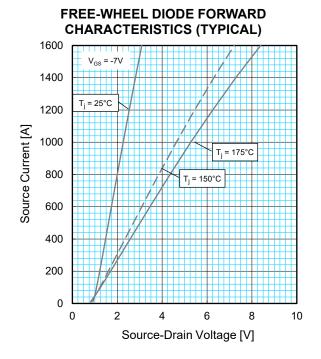
INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

#### **PERFPRMANCE CURVES**









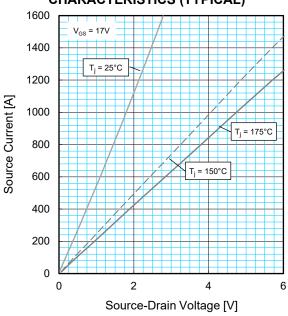
## FMF800DC-66BEW

**HIGH POWER SWITCHING USE** 

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

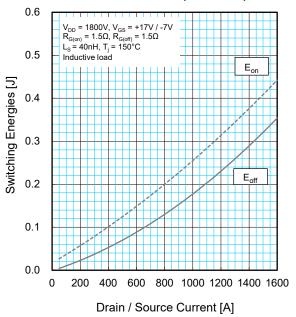
**PERFORMANCE CURVES** 

# FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

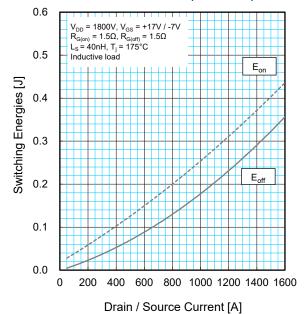


# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

**Preliminary** 



# HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



### FMF800DC-66BEW

**HIGH POWER SWITCHING USE** 

INSULATED TYPE 2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

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## FMF800DC-66BEW

**HIGH POWER SWITCHING USE** 

INSULATED TYPE 2<sup>nd</sup> gel

2<sup>nd</sup> gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

**Preliminary** 

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